

**Search Notes**

Application/Control No.

10/617,911

Examiner

Soon D. Hyun

Applicant(s)/Patent under  
Reexamination

YIP ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search for class/subclass and text; printout	12/11/2007	HY